Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/749,482	LEE, BYOUNG-JOON
Examiner	Art Unit
Andrew Lee	2663

SEARCHED					
Class	Subclass	Date	Examiner		
370	238,254	1/6/2006	AL		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor search and interference Search East	1/6/2006	AL		